

# 300SA Stage Accuracy Report

Customer Name:	GF - Singapore
System Description:	300SA Prober with ATT Chuck
System #:	QM2

## 25C Glass Accuracy

Wafer Used:	Precision Glass	
Measurement Method:	Image Recognition *Typical measurement uncertainty is $\pm 1\mu\text{m}$ **See Map on following page for die tested	
Minimum Error:	Xmin: $-8.5\mu\text{m}$	Ymin: $-8.2\mu\text{m}$
Maximum Error:	Xmax: $7.6\mu\text{m}$	Ymax: $11.2\mu\text{m}$
Specification:	$\pm 5\mu\text{m}$	
Pass/Fail:	PASS	

## 25C Glass Accuracy

Wafer Used:	Precision Glass	
Measurement Method:	Image Recognition *Typical measurement uncertainty is $\pm 1\mu\text{m}$ **See Map on following page for die tested	
Minimum Error:	Xmin: $-2.1\mu\text{m}$	Ymin: $-4.2\mu\text{m}$
Maximum Error:	Xmax: $5.3\mu\text{m}$	Ymax: $3.7\mu\text{m}$
Specification:	$\pm 5\mu\text{m}$	
Pass/Fail:	PASS	

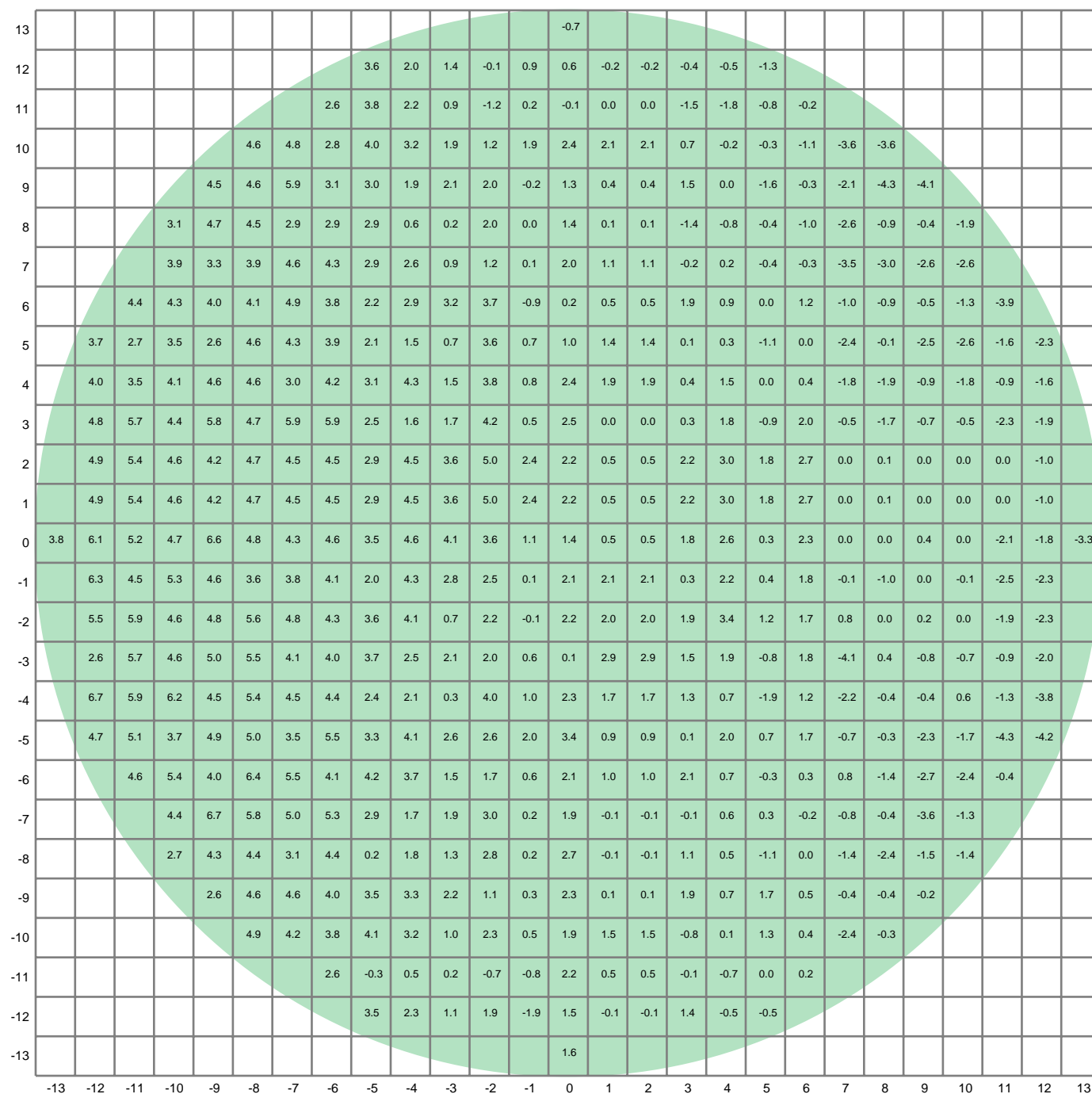
## 25C Glass Accuracy

Wafer Used:	Precision Glass	
Measurement Method:	Image Recognition *Typical measurement uncertainty is $\pm 1\mu\text{m}$ **See Map on following page for die tested	
Minimum Error:	Xmin: $-2.4\mu\text{m}$	Ymin: $-2.2\mu\text{m}$
Maximum Error:	Xmax: $3.2\mu\text{m}$	Ymax: $2.0\mu\text{m}$
Specification:	$\pm 5\mu\text{m}$	
Pass/Fail:	PASS	

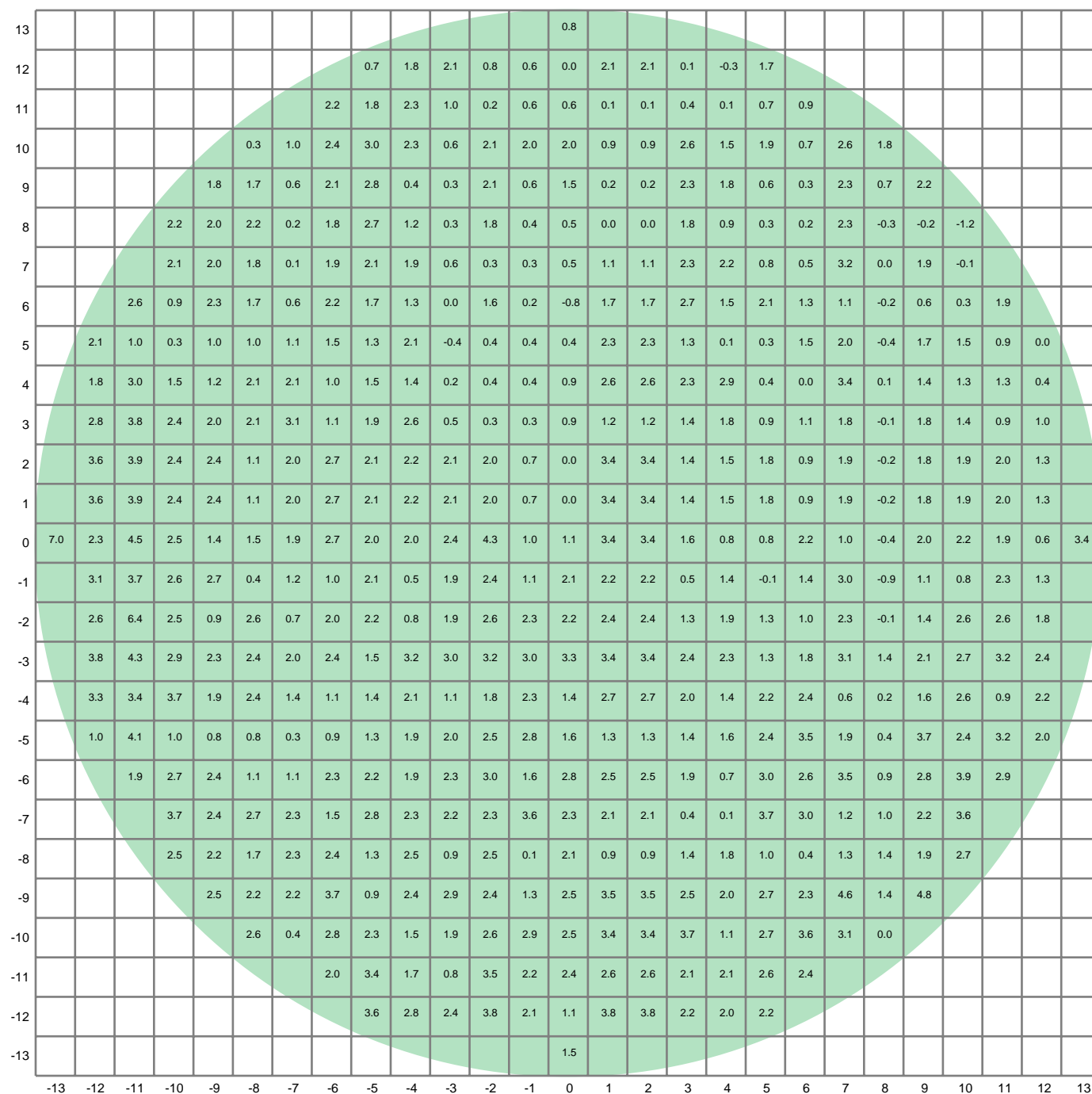
Performed by:	Remy Orans
Date:	29 Jul 2018

Signature: \_\_\_\_\_

X Axis Error Map (um)

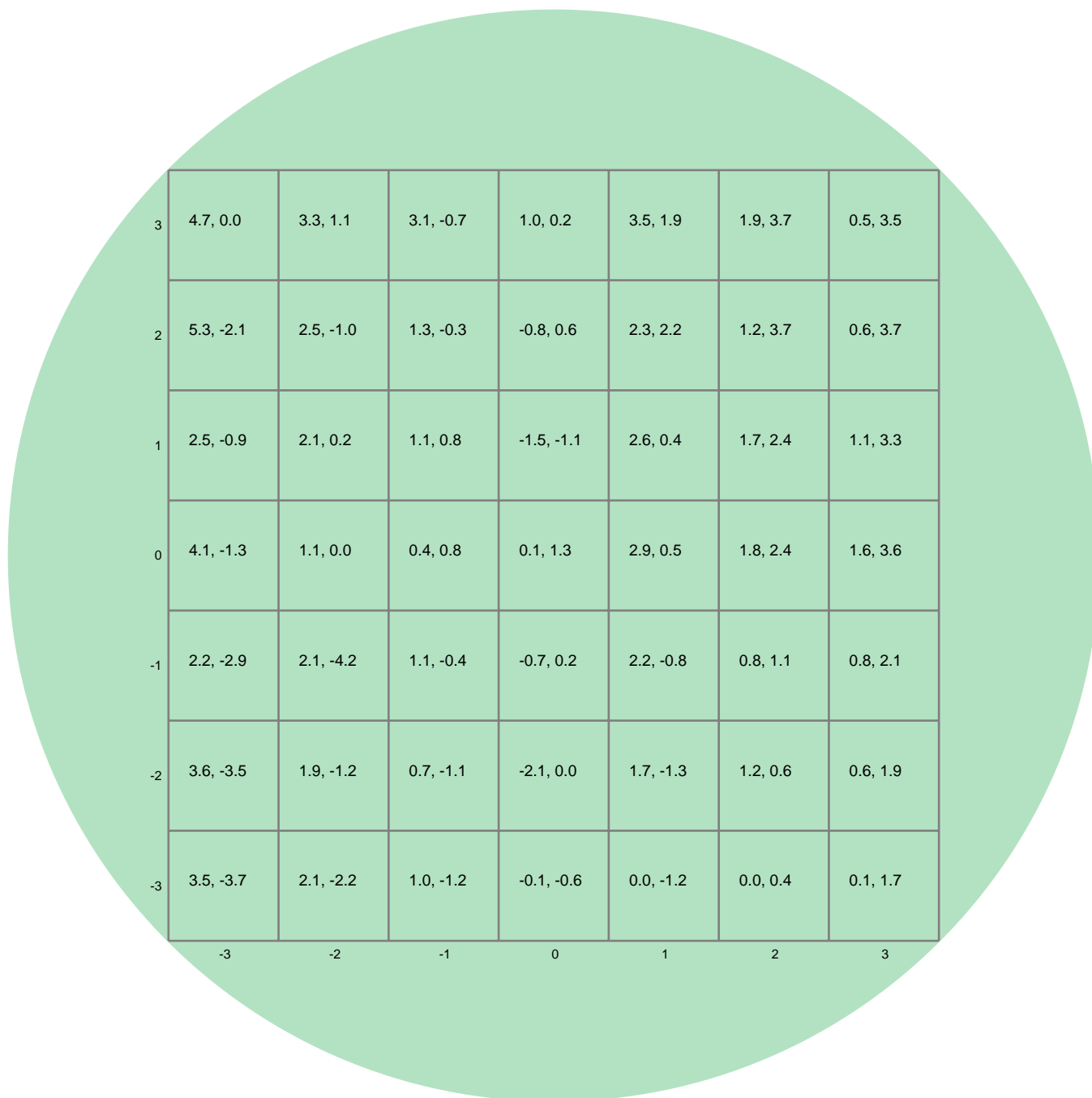


## Y Axis Error Map (um)



## 25C Glass Accuracy

X, Y Error Map (um)



## 25C Glass Accuracy

X, Y Error Map (um)

